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# A hydrothermally synthesized $\text{MoS}_{2(1-x)}\text{Se}_{2x}$ alloy with deep-shallow level conversion for enhanced performance of photodetectors

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Photoelectric detectors based on binary transition metal chalcogenides have attracted widespread attention in recent years. However, due to the high-temperature synthesis of binary TMD, high-density deep-level defect states may be generated, leading to poor responsiveness or a long response time. Besides, the addition of an alloy will change the DLDSs from deep to shallow energy levels caused by S vacancies. In this paper,  $\text{MoS}_{2(1-x)}\text{Se}_{2x}$  nanostructures were synthesized by a hydrothermal method, and a novel type of photodetector was fabricated by using the synthesized material as a light sensitive material. The MoSSe-based photodetector not only has a high photocurrent, but also exhibits a wide spectral response in the range of 405 nm to 808 nm. At the same time, it can achieve a responsivity of  $1.753 \text{ mA W}^{-1}$  under 660 nm laser irradiation of  $1.75 \text{ mW mm}^{-2}$ . Therefore, this work can be considered as a method of constructing a new type of photodetector with a simple process and low cost.

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## 1. Introduction

In recent years, graphene has attracted attention due to its good electrical conductivity,<sup>1</sup> efficient electron mobility,<sup>2</sup> and high light transmittance.<sup>3</sup> Although graphene's zero band gap makes it capable of absorbing light over a wide energy spectrum to generate charge carriers, it also causes the lifetime of photo-generated carriers to be greatly reduced. At the same time, its absorption coefficient is very low<sup>4,5</sup> and it cannot form a good switching ratio, and this greatly limits the application of graphene in optoelectronic devices. Hence, exploring two-dimensional (2D) graphene-like materials is of great significance to the development of optoelectronic devices. Meanwhile, as a typical 2D graphene-like material, transition metal dihalides (TMD) have attracted widespread attention because they have a band gap suitable for use in optoelectronic devices, and so they can overcome the shortcomings of graphene's zero band gap. Simultaneously, TMD also have the characteristics of a high electrical switching ratio,<sup>6</sup> high sensitivity photoelectric response,<sup>7</sup> and band gap changes with the number of layers.<sup>8</sup> So far, various TMD-based photodetectors have been reported in previous studies and have shown excellent performances. For example, Park *et al.* prepared multilayer  $\text{MoS}_2$  films by chemical exfoliation and applied them to near-infrared (NIR) photodetectors. The photodetector can achieve

a photocurrent close to  $0.528 \text{ mA cm}^{-2}$ .<sup>9</sup> To date, most research studies on TMD have focused on binary TMD, but the band gap flexibility of binary TMD is limited. Meanwhile, theoretical studies have shown that when binary TMD are synthesized at high temperatures, higher concentrations of defects will be generated, which will change local deep energy levels into defect states (this phenomenon is more likely to occur in small sizes).<sup>10,11</sup> The deep-level defect state (DLDS) can be used as a scattering center to reduce carrier mobility or as a photoelectron-hole recombination center to reduce the carrier lifetime. This will affect the performance of the photodetector.

To overcome this disadvantage, much effort has been made such as alloying,<sup>12–14</sup> molecular adsorption<sup>15</sup> and application of external strain.<sup>16</sup> Of all the above mentioned methods, alloying in materials provides a versatile, stable, and industrially scalable method for adjusting physical properties to optimize and scale performance. Hence, exploring a simple method for preparing high-quality ternary TMD alloys is of great significance for the application of high-performance photodetectors based on TMD materials. Current ternary alloy synthesis methods are focused on chemical vapor deposition (CVD). Lim *et al.* prepared  $\text{MoS}_{2(1-x)}\text{Se}_{2x}$  ternary alloys that can be used in industrial applications by a CVD method. The alloy material device can show a high light-dark current ratio up to 1000 at 0.5 V.<sup>17</sup> Even using a CVD method to synthesize materials can achieve morphological control and higher purity. However, the shortcomings of high reaction conditions, the inability to achieve large-scale synthesis and the difficulty in transferring severely hinder their application in photodetectors.

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In this work, we synthesized the  $\text{MoS}_{2(1-x)}\text{Se}_{2x}$  nanostructure using a simple hydrothermal method. And then vacuum suction filtration is used to form a uniform and dense film on the organic filter membrane which has the advantages of low price and easy access compared with other substrates. The device prepared using the MoSSe material shows a wide spectral response, and its photocurrent and corresponding responsivity under  $1.75 \text{ mW mm}^{-2}$  660 nm laser irradiation are  $12.6 \mu\text{A}$  and  $1.753 \text{ mA W}^{-1}$ , respectively. At the same time, compared with devices made of pure  $\text{MoS}_2$  and  $\text{MoSe}_2$  materials with the same synthesis method, the photocurrent is significantly increased. Hence, alloying is considered as an effective method to effectively improve the separation of photogenerated electron-hole pairs. Herein, we believe that this work provides a feasible method for developing new alloying TMD materials and relevant optoelectronic devices.

## 2. Experimental

### Materials

Hydrazine hydrate ( $\text{N}_2\text{H}_4 \cdot \text{H}_2\text{O}$ , 80%), ammonium molybdate tetrahydrate ( $(\text{NH}_4)_6\text{Mo}_7\text{O}_{24} \cdot 4\text{H}_2\text{O}$ , 99%), thiourea, hydrochloric acid (HCl, 36–38%), selenium powder (Se, 99.9%), and *N*-methyl-2-pyrrolidone (NMP). All the chemicals were of analytical grade and used without further purification.

### Synthesis of MoSSe

In a typical synthesis process of 3.5 mmol of thiourea, 3.5 mmol of Se and 0.5 mmol of  $(\text{NH}_4)_6\text{Mo}_7\text{O}_{24} \cdot 4\text{H}_2\text{O}$  are dissolved in a mixed solution of  $\text{H}_2\text{O}$  and ethanol with a volume ratio of 1 : 1 under magnetic stirring. Then, 10 mL of  $\text{N}_2\text{H}_4 \cdot \text{H}_2\text{O}$  and 5 mL of NMP were added in the solution and stirred to obtain a homogeneous mixed solution. The solution was transferred to a stainless steel autoclave lined with Teflon and placed in an oven at  $200^\circ\text{C}$  for 24 hours. A black powder was collected by centrifugation and washed several times with ethanol and deionized water, and then the product was dried overnight in a vacuum oven at  $60^\circ\text{C}$ .  $\text{MoSe}_2$  and  $\text{MoS}_2$  samples were also obtained following a similar procedure without adding S or Se, respectively. The names of different  $\text{MoS}_{2(1-x)}\text{Se}_{2x}$  samples depend on the addition ratio of selenium powder and thiourea during the synthesis process.

### Characterization

The crystal structures of the as-prepared samples were determined by X-ray diffraction (XRD) with  $\text{Cu/K}\alpha$  radiation. The morphologies of the as-prepared samples were analyzed using a VEGA3 SBH type scanning electron microscope (SEM) produced by Tescan. The UV-Vis (UV-vis) absorption spectrum in the wavelength range of 400 to 800 nm was measured using a Shimadzu UV-vis spectrophotometer (ISR-2200, Shimadzu).

### Device fabrication and measurements

Materials of equal quality were dissolved in 20 mL of water and sonicated for 20 minutes to make them uniformly dispersed. The material was then filtered through an organic filter

membrane using a circulating water vacuum pump and placed in a  $30^\circ\text{C}$  vacuum drying oven overnight. A JSD-300 evaporation coating machine and a mold with a distance of 100  $\mu\text{m}$  were used to manufacture metallic Cu interdigital electrodes. All photoelectric measurements were performed using Keithley's 2612B semiconductor characterization system, and five lasers with wavelengths of 405 nm, 450 nm, 532 nm, 660 nm and 808 nm were used. The power of all lasers was measured using a power meter (Thorlabs PM100D).

## 3. Results and discussion

Fig. 1(a) and (b) show the schematic diagrams of materials synthesis and device preparation, respectively, and the Experimental section has provided a detailed synthesis process and preparation process. The optical photo of the device is given at the end in Fig. 1(b). The distance between the two electrodes (source and drain) of the device is about 100  $\mu\text{m}$ . Fig. 1(c)–(f) show SEM images of  $\text{MoS}_{2(1-x)}\text{Se}_{2x}$  nanostructures with different selenium contents. The images show that the sizes of MoSSe,  $\text{MoS}_2$  and  $\text{MoSe}_2$  are 0.3–0.9  $\mu\text{m}$ , 0.5–1  $\mu\text{m}$ , and 0.4–1.5  $\mu\text{m}$ , respectively. From the SEM images of the three samples, it can be seen that all the samples showed an uneven distribution, and many particles seemed to pile up and fuse together. The generation of particle stacks can be explained by the Ostwald ripening mechanism.<sup>18,19</sup> In the synthesis process, small particles are formed first, and the energy of the molecule on the surface of the particle is higher than the energy of the molecule inside the particle, leading to instability of particles. As a result, small particles will dissolve and deposit again on larger particles.

XRD measurements have been performed to explore the structural characterization of the as-prepared samples. The XRD pattern of the  $\text{MoS}_2$  sample showed that the diffraction peaks located at angles ( $2\theta$ ) of about  $34.9^\circ$  and  $58.8^\circ$ , correspond to the (100) and (110) crystal faces of hexagonal  $\text{MoS}_2$ , which is consistent with the literature. For the  $\text{MoSe}_2$  sample, three broad XRD peaks were observed at  $2\theta = 33.8^\circ$ ,  $41.6^\circ$  and  $54.4^\circ$ , corresponding to the (100), (103) and (110) crystal planes of the hexagonal  $\text{MoSe}_2$  (ref. code # 98-060-1045).<sup>20–22</sup> Three characteristic peaks at angles of  $34.3^\circ$ ,  $42.7^\circ$  and  $56.4^\circ$  can be observed in the XRD pattern of the MoSSe sample. However, compared with the characteristic peaks of  $\text{MoSe}_2$ , the positions are shifted to a certain degree and the intensity of the characteristic peaks is weakened. This is because the radius of the Se atom is larger than that of the S atom, which leads to a change in the lattice distance.<sup>23,24</sup> The XRD patterns of all samples showed high noise, which indicates that the crystallinity of the samples was low, and no other peaks were observed, indicating that there were no phase impurities in the samples.

In addition, UV-vis spectra of the MoSSe,  $\text{MoS}_2$  and  $\text{MoSe}_2$  are displayed in Fig. 2(b). From the absorption spectrum comparison of the three samples, it can be known that the absorption capacity of the spectrum absorption intensity in the range of 400 nm to 800 nm is  $\text{MoSe}_2 > \text{MoSSe} > \text{MoS}_2$ , which is consistent with the literature.<sup>25–27</sup> The UV-vis spectra show that the absorption edges of MoSSe,  $\text{MoS}_2$  and  $\text{MoSe}_2$  are about 826



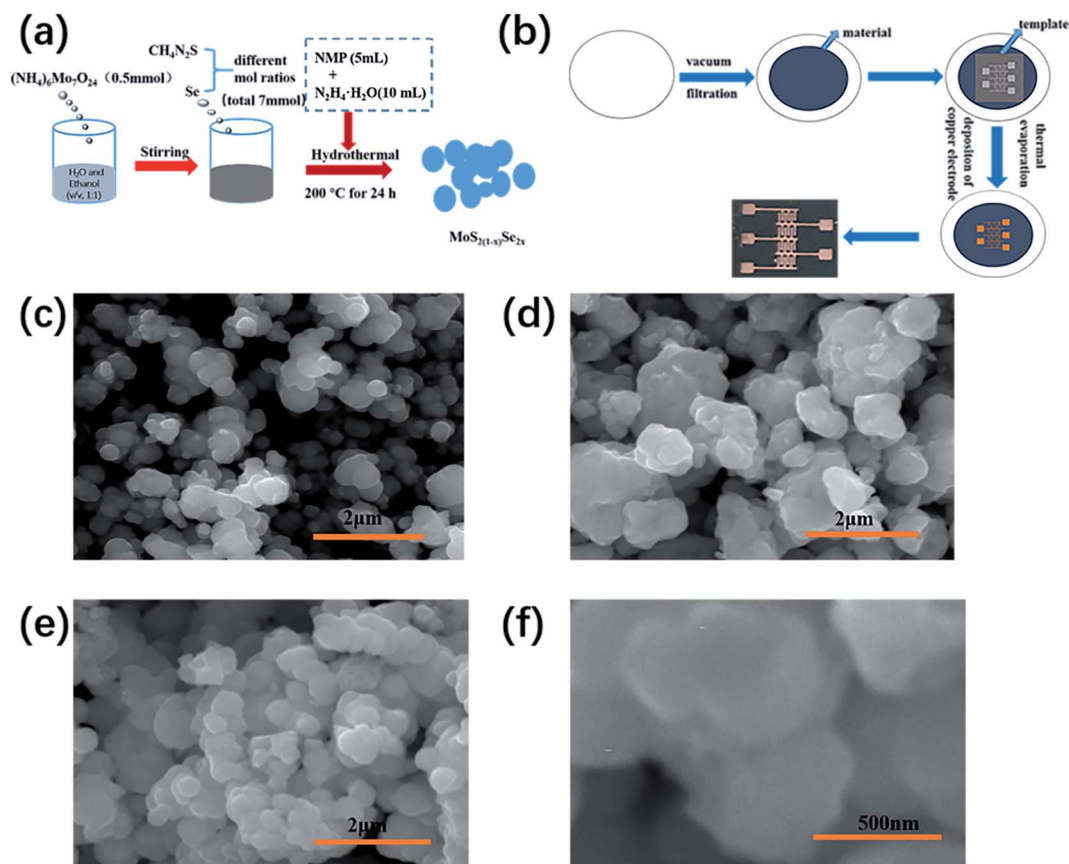


Fig. 1 (a) Schematic diagram of  $\text{MoS}_{2(1-x)}\text{Se}_{2x}$  synthesis, (b) schematic diagram of device preparation, and SEM images of (c)  $\text{MoS}_2$ , (d)  $\text{MoSe}_2$  and (e and f)  $\text{MoSSe}$ .

nm, 760 nm, 864 nm, respectively. According to the formula:<sup>28</sup>

$E \text{ (eV)} = \frac{hc}{\lambda}$ , where  $E$ ,  $h$ ,  $\lambda$  and  $c$  are the band gap energy of the semiconductor material, Planck constant, wavelength of light and speed of light, respectively. Therefore, the band gaps of  $\text{MoSSe}$ ,  $\text{MoS}_2$  and  $\text{MoSe}_2$  can be calculated to be approximately 1.5 eV, 1.63 eV and 1.43 eV, respectively, which is the same as the previous report.<sup>29</sup>

Fig. 3(a) shows the current-voltage ( $I$ - $V$ ) characteristics of the  $\text{MoSSe}$  sample. By comparing dark conditions at a constant power density ( $1.75 \text{ mW mm}^{-2}$ ) and laser irradiation at different wavelengths, it was found that the maximum photocurrent response can be obtained under 660 nm irradiation.

The linearity of the current-voltage curve can be attributed to the ohmic contact between the sample and the metal electrode,<sup>30</sup> which is considered to be beneficial for the extraction of photo-generated carriers. To further explore the sensitivity of photodetectors at different wavelengths, Fig. 3(b) shows the photoresponse over time at a low voltage and the same power density. The photocurrent under laser irradiation of 405 nm, 450 nm, 532 nm, 660 nm and 808 nm is 12.3  $\mu\text{A}$ , 9.3  $\mu\text{A}$ , 8.7  $\mu\text{A}$ , 12.6  $\mu\text{A}$ , and 8.0  $\mu\text{A}$ , respectively. At the same time, it can be seen that these devices show stable and repeatable photoresponse characteristics under irradiation with five lasers of different wavelengths. Fig. 3(c) shows the photoresponse of  $\text{MoSSe}$  samples over time at a constant power density and

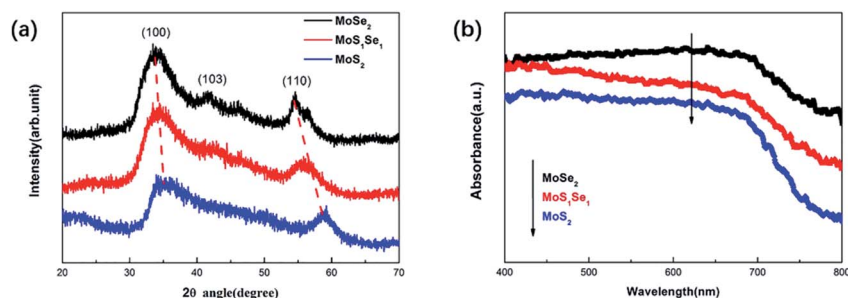


Fig. 2 (a) XRD patterns of  $\text{MoS}_2$ ,  $\text{MoSSe}$  and  $\text{MoSe}_2$ , and (b) UV-vis spectra of  $\text{MoS}_2$ ,  $\text{MoSSe}$  and  $\text{MoSe}_2$ .

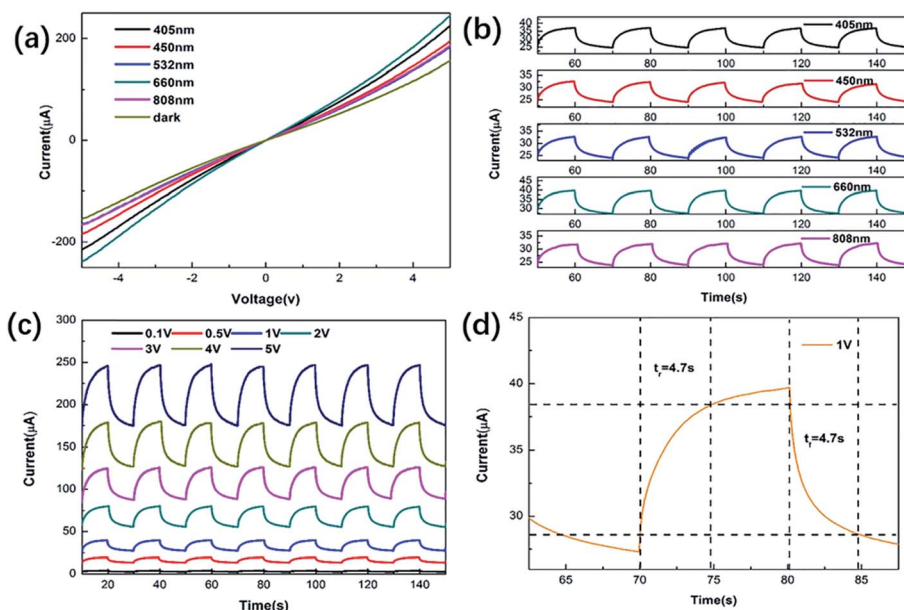


Fig. 3 Photoelectric characteristics of the MoSSe photodetector (a)  $I$ - $V$  curves at different wavelengths under dark conditions and at constant power ( $1.75 \text{ mW mm}^{-2}$ ), (b) the time-dependent photoresponse under irradiation with various lasers of  $1.75 \text{ mW mm}^{-2}$  at 1 V bias, (c) time-dependent photoresponse at different voltages, and (d) rise and fall times at a 1 V potential.

different bias voltages. As the voltage increases, the dark current and photocurrent also increase. This is a reflection of the potential gradient caused by the external bias in MoSSe. By controlling the external bias, the photocurrent can be reasonably optimized. Response time (rise time and fall time) is an important parameter of light detection. Rise time ( $t_r$ ) is defined as the time taken for the photogenerated current to rise from

10% to 90% and the time required to reduce the photo-generated current from 90% to 10% is defined as the fall time ( $t_f$ ).<sup>31</sup> The rise and fall times of MoSSe photodetectors at a constant power density of  $1.75 \text{ mW mm}^{-2}$  and 1 V are 4.7 s and 4.7 s, as shown in Fig. 3(d). Compared with other photodetectors, the performance of our prepared devices is not very outstanding. This is because (1) the crystallinity of the material

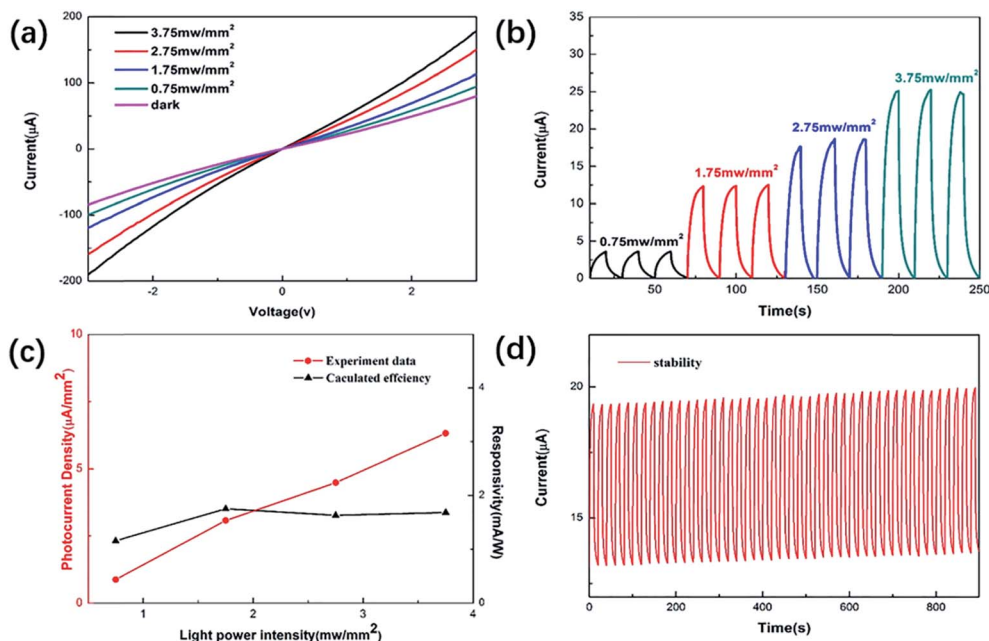


Fig. 4 (a) The  $I$ - $V$  curves of MoSSe samples under dark conditions and at different power densities, (b) photocurrent of the device at various power densities, (c) calculated photoconversion efficiencies of the device at various power densities, and (d) cycling stability measurements of the device.





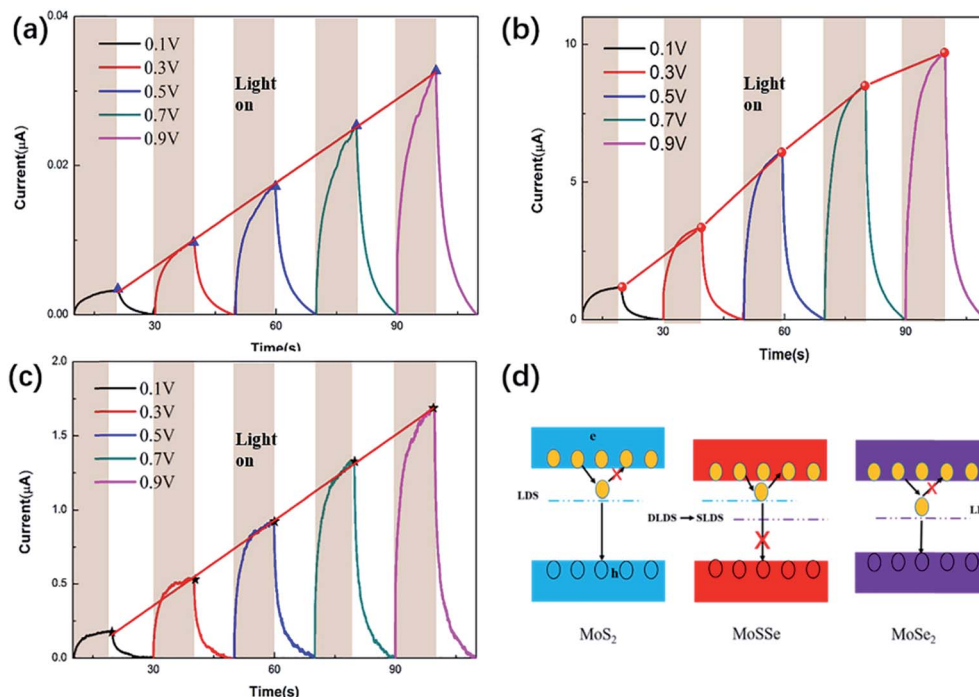


Fig. 5 The photocurrents of (a) MoS<sub>2</sub>, (b) MoSSe and (c) MoSe<sub>2</sub> at different bias voltages, and (d) schematic plot of the concept for suppressing DLDSs in MoSSe compared to MoS<sub>2</sub> and MoSe<sub>2</sub> by alloy engineering.

synthesized by the hydrothermal method is low; (2) the materials are stacked together, causing the photo-generated carriers to be scattered by impurities and defects; (3) the distance between the source and drain of the device is too long, which results in a longer carrier transmission path.

Fig. 4(a) and (b) show the  $I$ - $V$  and time-dependent photo-response under 660 nm laser irradiation at different optical power densities, respectively. The results show that the photocurrent increases with increasing light intensity. This is because a higher light intensity generates more non-equilibrium carriers, which leads to an increase in photocurrent. Meanwhile, the steady photocurrent is about 3.56  $\mu\text{A}$  when the light intensity is 0.75  $\text{mW mm}^{-2}$ . The value of responsivity ( $R$ ) can be obtained from the following equation:<sup>32,33</sup>  $R = I/J_{\text{light}}$ , where  $I$  is the photocurrent density and  $J_{\text{light}}$  is the irradiance intensity. The relationship between photoelectric responsivity and irradiance power intensity is shown in Fig. 4(c). The optical

responsivity of the device can reach 1.753  $\text{mA W}^{-1}$ . In addition to photoelectric responsivity, the stability of photodetectors is another key factor that should be evaluated before practical application. Hence, cycling stability measurements were performed on the device and are shown in Fig. 4(d). Through continuous switching operation of the device for 900 s, it is found that the photocurrent has almost no attenuation, which indicates that the stability of the device is relatively high, and it also shows that the MoSSe alloy synthesized using the hydrothermal method has high stability. It can also be found that the dark current increases with time. This is because the trapped state in the channel material would prolong the life of the non-equilibrium carriers so the dark current would take longer to recover to the initial equilibrium state.

Fig. 5(a)–(c) show the time-dependent photoresponse of the three samples MoS<sub>2</sub>, MoSSe and MoSe<sub>2</sub> at a constant power and different bias voltages. As a result, the photocurrent of the

Table 1 Comparison of different parameters of MoSSe and other related materials for photodetectors

Device structure	Method	Wavelength (nm)	Responsivity ( $\text{mA W}^{-1}$ )	$\tau_r/\tau_f$ (s)	Ref.
Ti/MoS <sub>2</sub> /Si/Au <sup>b</sup>	Thermal decomposition	550	—	13/30	35
Au/MoS <sub>2</sub> /Au <sup>a</sup>	Mechanical exfoliation	561	$8.8 \times 10^5$	4/9	36
MoSe <sub>2</sub> /Si <sup>b</sup>	CVD	650	0.26	0.025/0.025	37
Ti/MoSe <sub>2</sub> /Ti <sup>b</sup>	Mechanical exfoliation	532	$9.7 \times 10^4$	0.015/0.030	38
Ti/Mo <sub>0.5</sub> W <sub>0.5</sub> Se <sub>2</sub> /Au <sup>a</sup>	PLD	532	$77.1 \times 10^3$	—	10
Au/MoS <sub>1.15</sub> Se <sub>0.85</sub> /Au <sup>a</sup>	CVD	532	$2.06 \times 10^3$	18/35	39
Cu/MoSSe/Cu <sup>a</sup>	Hydrothermal	660	1.753	4.7/4.7	This work

<sup>a</sup> Photoconductive type. <sup>b</sup> Phototransistors.



MoS<sub>2</sub>-based device was higher than that of the MoS<sub>2</sub> and MoSe<sub>2</sub>-based devices, as expected. This is because binary TMD will generate defects of S group vacancies during high temperature synthesis, and these defects will cause DLDs. On the one hand, DLDs act as scattering centers, which impede carrier transmission. At the same time, DLDs are effective recombination centers of photo-generated electron-hole pairs, which greatly shorten the carrier lifetime.<sup>34</sup> Fig. 5(d) shows the schematic plot of the concept for suppressing DLDs in MoS<sub>2</sub> compared to MoS<sub>2</sub> and MoSe<sub>2</sub> by alloy engineering. As shown in Fig. 5(d), the energy state of the conduction band minimum of MoS<sub>2</sub> is lower than the energy state of MoS<sub>2</sub> and is close to the energy state of MoSe<sub>2</sub>. Therefore, the S vacancy in MoS<sub>2</sub> can transfer the captured electrons back to the conduction band to become free electrons, instead of combining with holes in the valence band.<sup>41</sup> This will help reduce the recombination of photogenerated electron-hole pairs and increase the lifetime of photogenerated carriers.

## 4. Conclusions

In summary, we synthesized MoS<sub>2</sub>(1-x)Se<sub>2x</sub> (x = 0, 0.5, 1) nanostructures *via* a simple hydrothermal method. The filter membrane was directly used as a substrate by vacuum filtration, and the copper electrode was thermally evaporated and deposited on the surface of the material. The experimental results show that the photodetector based on the alloyed MoS<sub>2</sub> material has a higher photocurrent at the same bias voltage and constant power, and the photodetector shows a stable and repeatable photoresponse at different wavelengths of incident light. At the same time, we have compared with some related photodetectors (Table 1), and we can see that our photodetectors have some advantages in terms of response time. All the results show that this work provides a feasible method for the development of low-cost, wide-spectrum (visible spectral range) photodetectors.

## Conflicts of interest

There are no conflicts of interest to declare.

## Acknowledgements

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